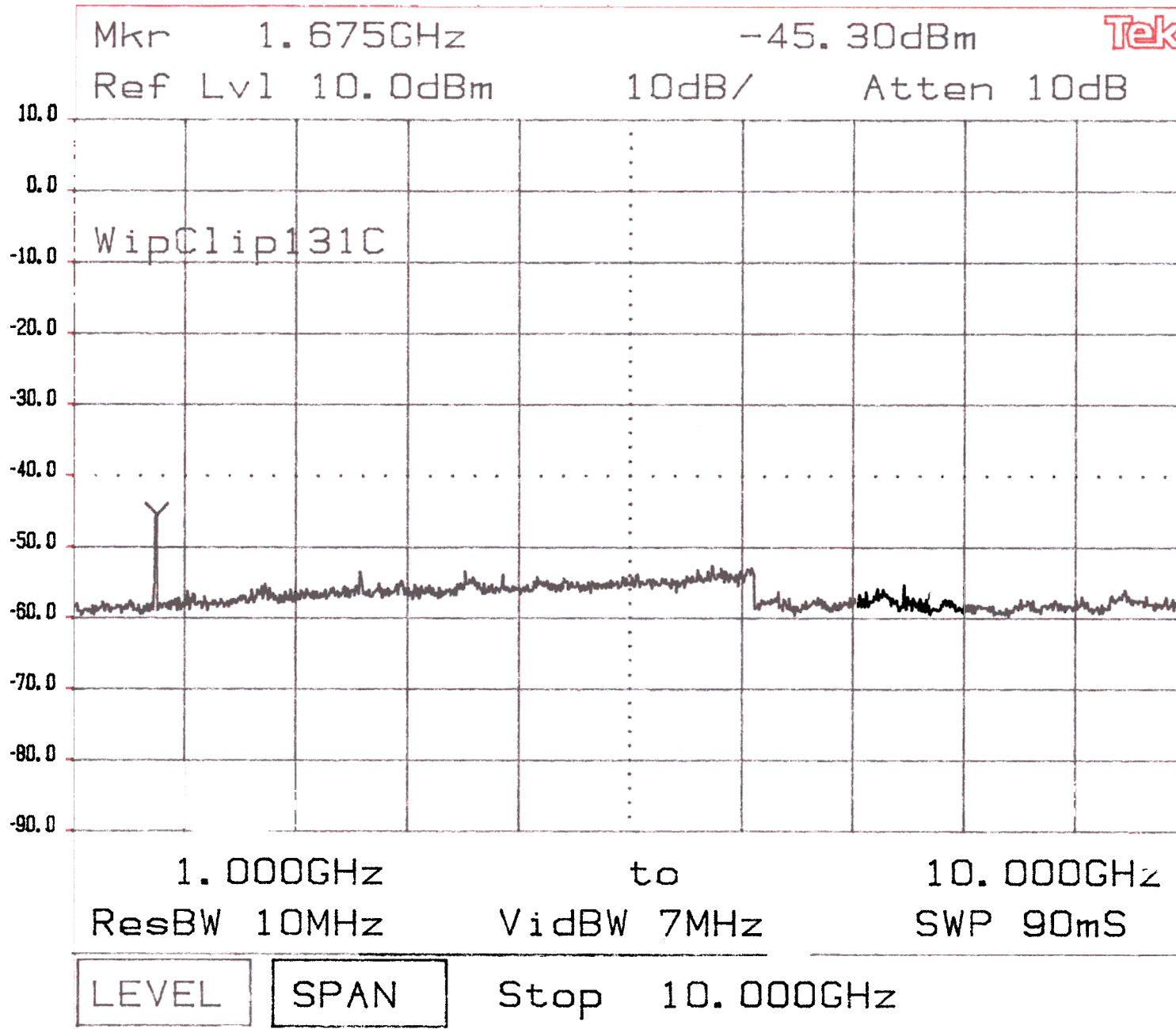


Plot #7.3.2.b



Knob 2

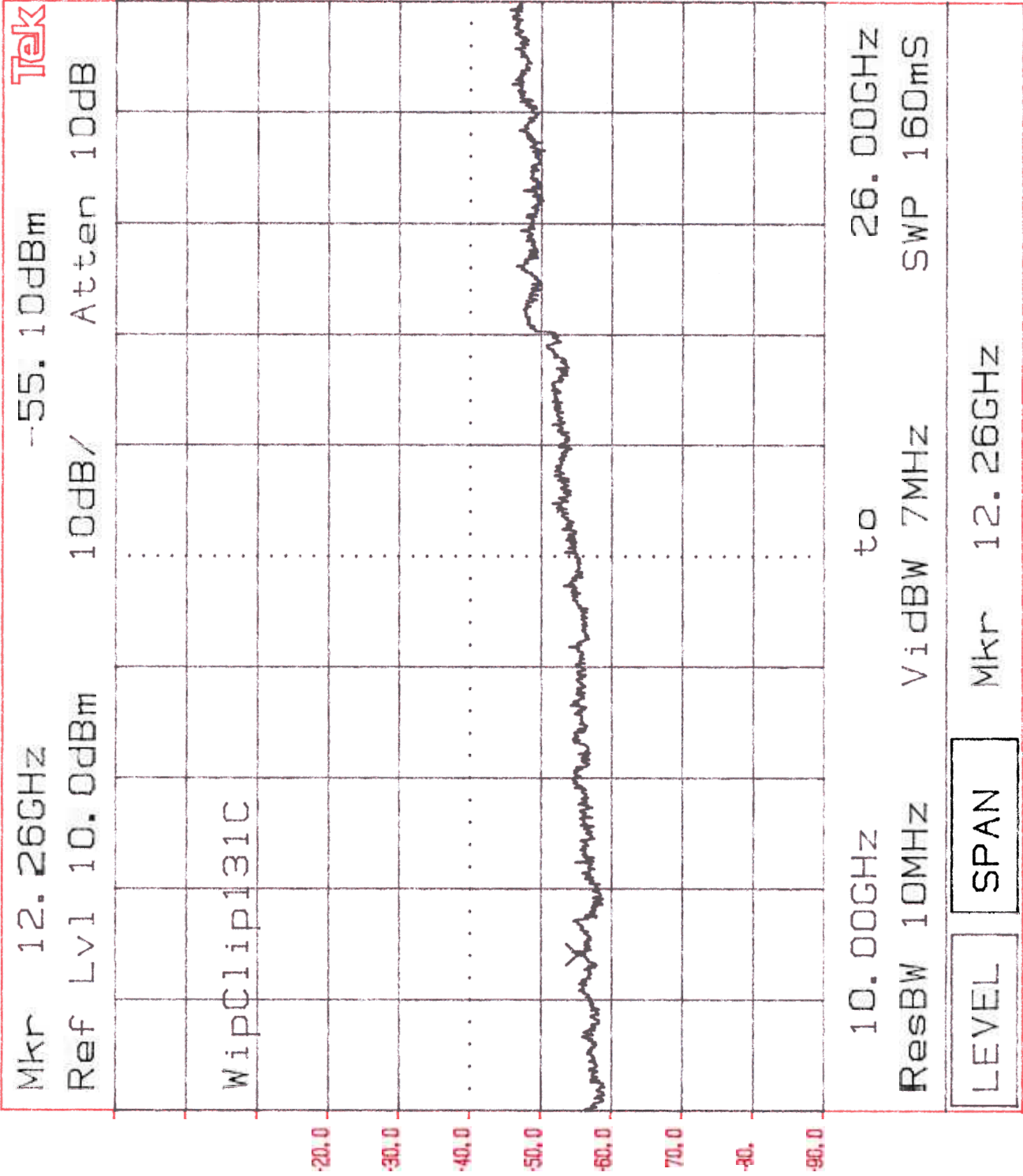
Knob

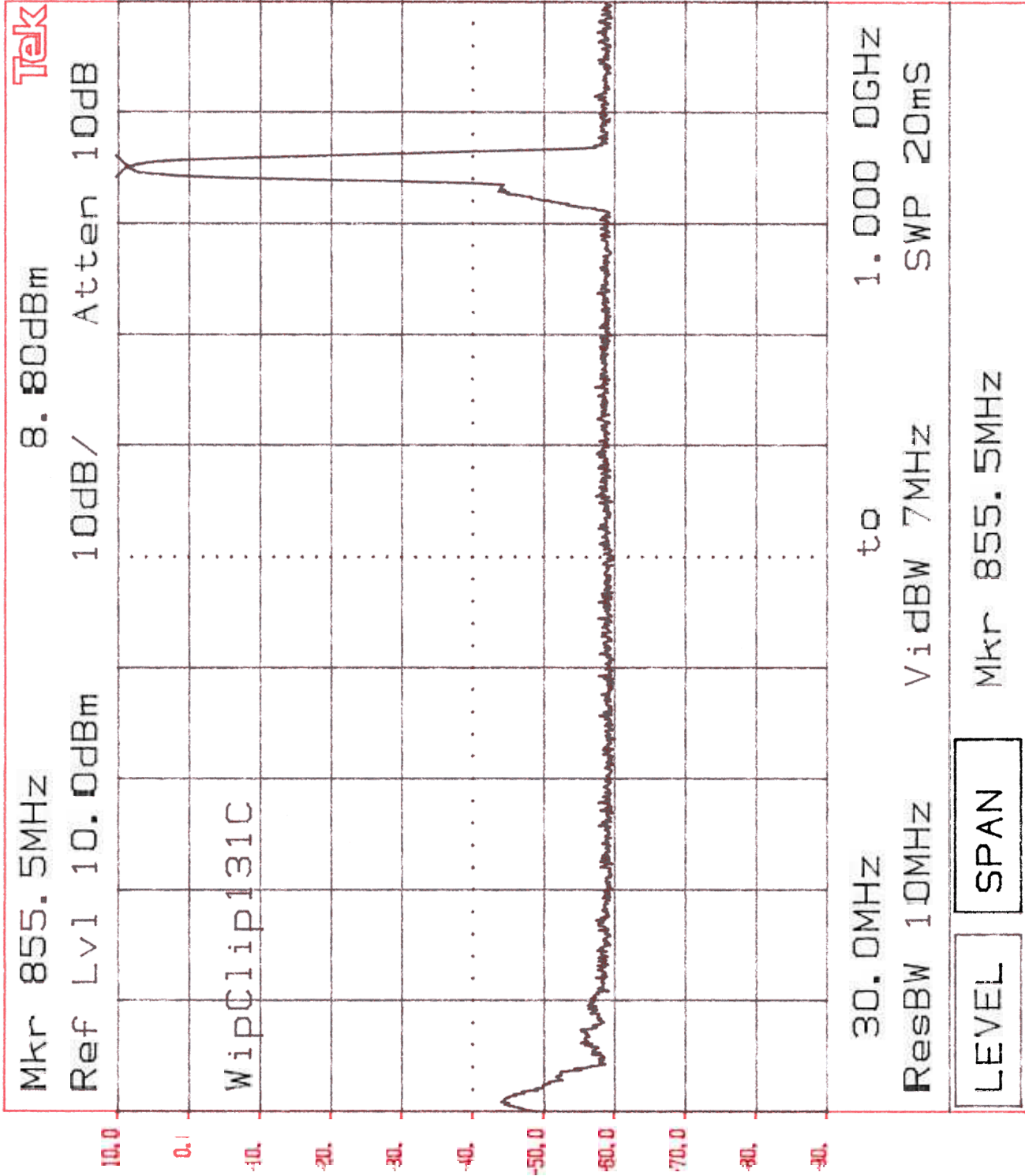
Keypad

Tektronix

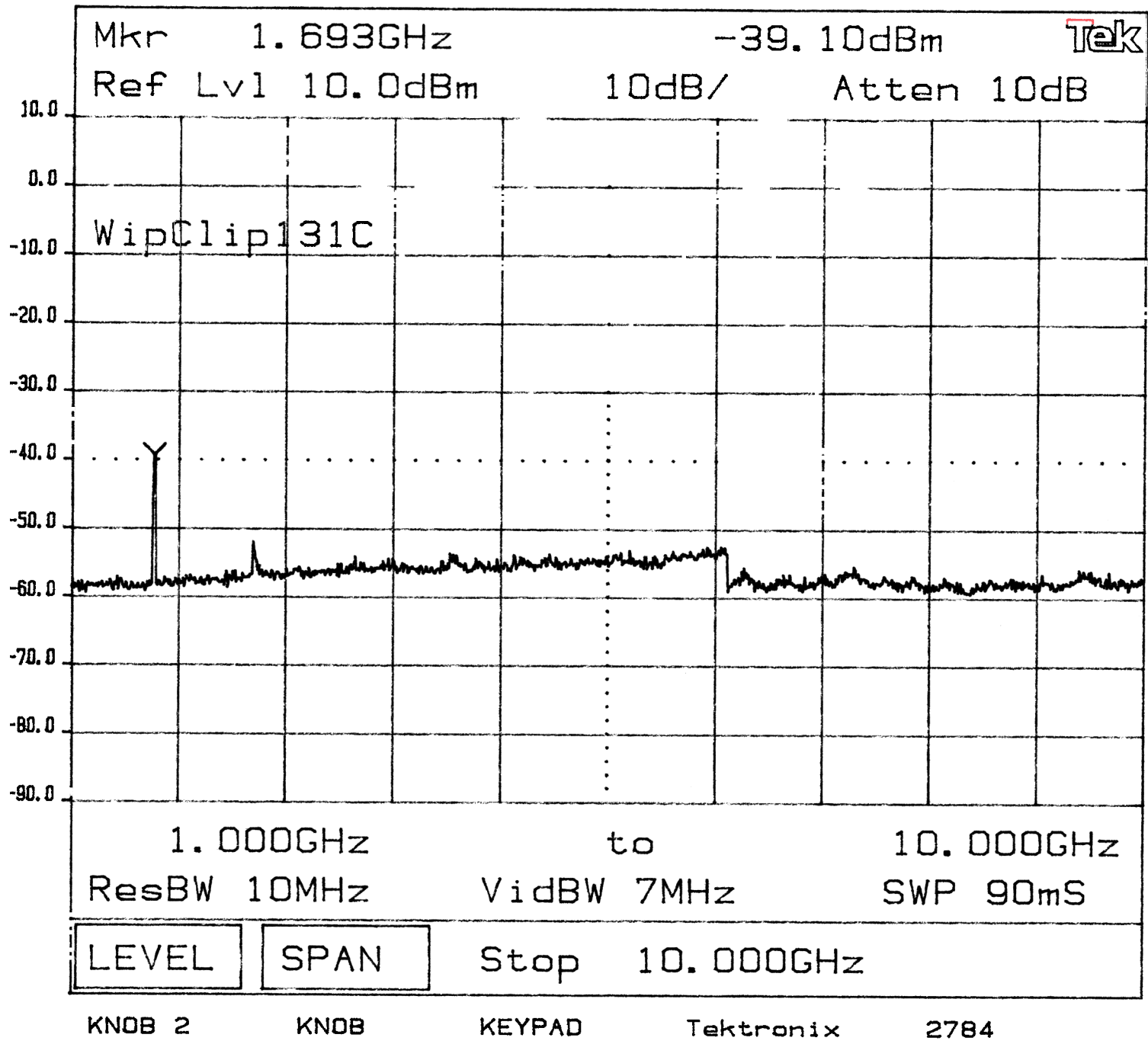
2784

plot # 7 3 2 0 0

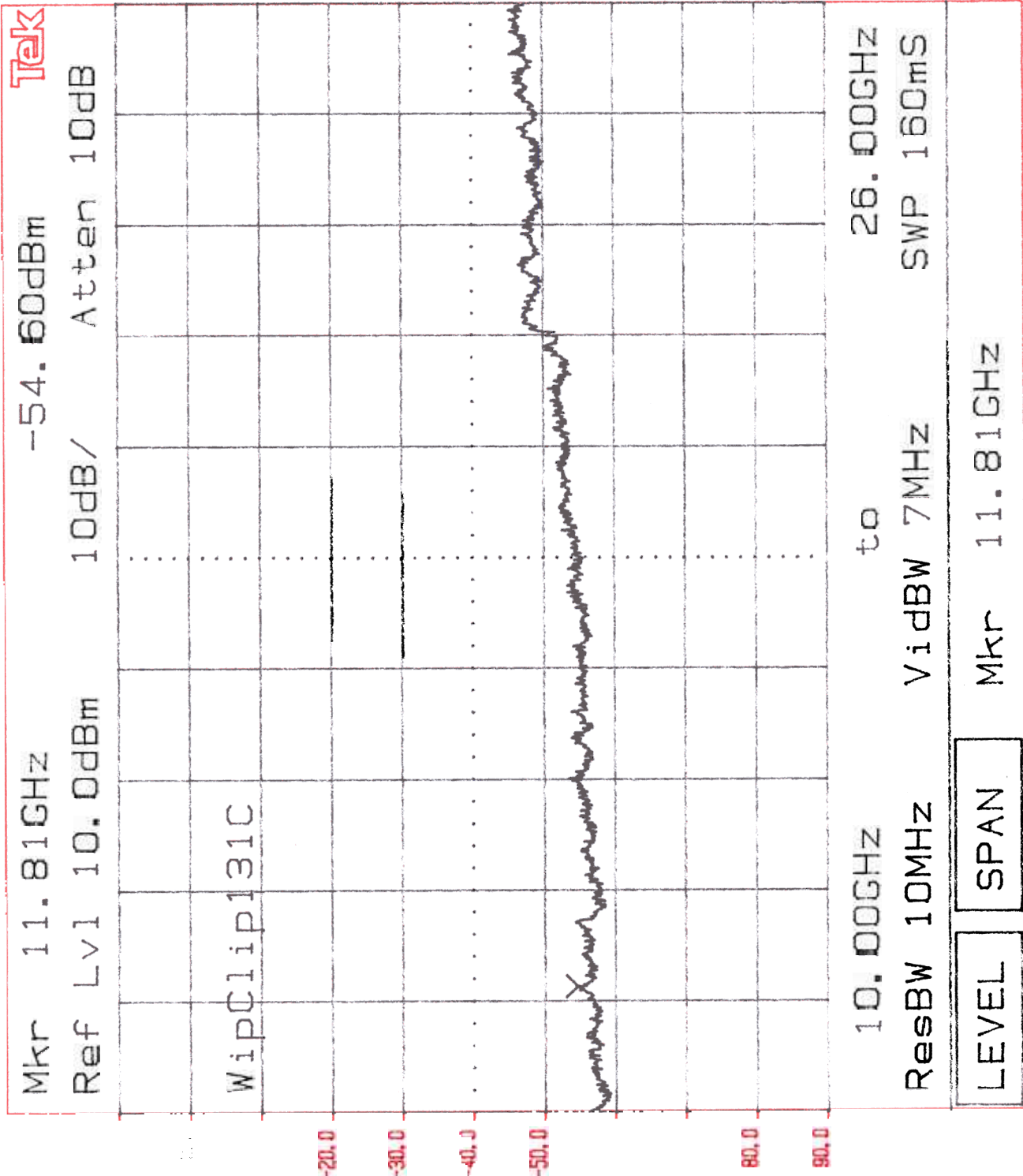




Plot # 7.3.3.b



plot 11 3



KNOB KNOB KEYPAD elektron1 2784

Tellus Technology Inc, Wireless Modem
 FCC ID: NZ6V8131C

Date of Test: January 15 – 18 & 30, 2001

8.0 Field Strength of Spurious Radiation
 FCC 2.1053

8. Test Procedure

The frequency range up to tenth harmonic of each of the three fundamental frequencies (low, middle, and high channels) was investigated.

The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and polarization as well as EUT azimuth were varied in order to identify the maximum level of emissions from the EUT.

At each spurious emission frequency the ERP was measured by the substitution method using a generator and horn antenna. The spurious emissions attenuation was calculated as the difference between ERP in dBm at the fundamental frequency (See Section 3) and at the spurious emissions frequency.

The radiated emissions from digital parts and receiver local oscillator were measured as well.

8.2 Test Equipment

- EMCO 3143 Bilog Antenna
- EMCO 3115 Horn Antenna
- HP 8566B Spectrum Analyzer
- Tektronix 2782 Spectrum Analyzer
- Low Pass Filter
- Preamplifier

8.3 Test Results

Test Result: Passed, refer to the attached

Data Sheet No	Description
8.3.a	Radiated Emissions FCC 15B
8.3.b	Radiated Emissions, Receiver LO & Harmonics
8.3.c	Radiated Emissions Harmonics, Low Channel
8.3.d	Radiated Emissions Harmonics, Mid Channel
8.3.e	Radiated Emissions Harmonics, High Channel
8.3.f	Radiated Emissions by substitution method, Low Channel
8.3.g	Radiated Emissions by substitution method, Mid Channel
8.3.h	Radiated Emissions by substitution method, High Channel